MPX2010 Series

10 kPa Temperature Compensated Pressure Sensors

Rev. 14 — 27 April 2021

Product data sheet

1 General Description

The MPX2010 series device is a silicon piezoresistive pressure sensor providing a highly accurate and linear voltage output directly proportional to the applied pressure. The sensor is a single monolithic silicon diaphragm with the strain gauge and a thin-film resistor network integrated on-chip. The chip is laser trimmed for precise span and offset calibration and temperature compensation.

2 Features and Benefits

- Ratiometric to Supply Voltage
- Differential and Gauge Options
- Temperature Compensated over 0 °C to 85 °C
- Easy-to-Use Chip Carrier Package Options

3 Applications

- Air Movement Control
- · Respiratory Diagnostics
- Controllers
- · Pressure Switching



4 Ordering Information

Davies nome	Package	Case number	Nu	mber of po	orts		Pressure type	Bardan maddan	
Device name	options		None	Single	Dual	Gauge	Differential	Absolute	Device marking
Small Outline Pack	age (MPXV201) Series)						'	
MPXV2010GP	Tray	<u>1369</u>		•		•			MPXV2010GP
MPXV2010DP	Tray	<u>1351</u>			•		•		MPXV2010DP
Unibody Package ((MPX2010 Serie	s)			1				
MPX2010D	Tray	344	•				•		MPX2010D
MPX2010DP	Tray	344C			•		•		MPX2010DP
MPX2010GP	Tray	<u>344B</u>		•		•			MPX2010GP
MPX2010GSX	Tray	<u>344F</u>		•		•			MPX2010D
MPAK Package (M	PXM2010 Serie	s)			'	'		'	
MPXM2010GS	Rail	<u>1320A</u>		•		•			MPXM2010GS
MPXM2010GST1	Tape & Reel	<u>1320A</u>		•		•			MPXM2010GS

Small outline packages



MPXV2010GP Case 1369-01



MPXV2010DP Case 1351-01

MPAK Packages



MPXM2010GS/GST1 Case 1320A-02

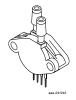
Unibody Packages



MPX2010D Case 344-15



MPX2010GP Case 344B-01



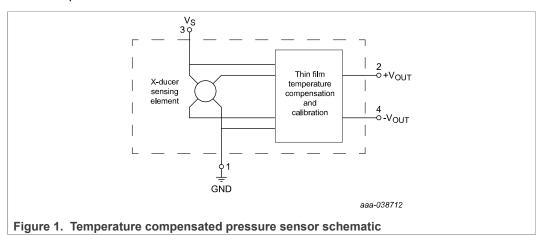
MPX2010DP Case 344C-01



MPX2010GSX Case 344F-01

5 Block Diagram

<u>Figure 1</u> shows a block diagram of the internal circuitry on the stand-alone pressure sensor chip.



Pin Information

6.1 MPX2010D

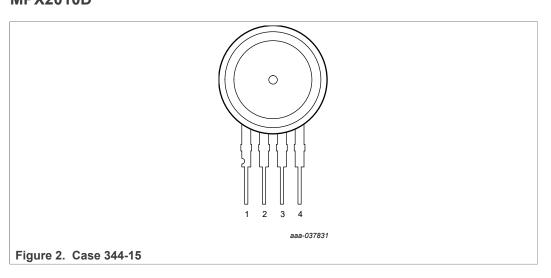


Table 1. Pin definitions - MPX2010D

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output

6.2 MPX2010DP

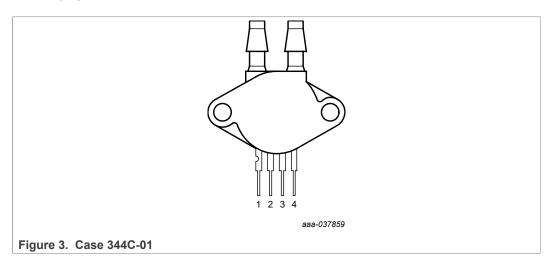


Table 2. Pin definitions - MPX2010DP

Table 2. Till definitions - Wi A2010B1							
Symbol	Pin	Description					
GND	1	Ground					
+V _{OUT}	2	+ Voltage output					
Vs	3	Power supply					
-V _{OUT}	4	- Voltage output					

6.3 MPX2010GP

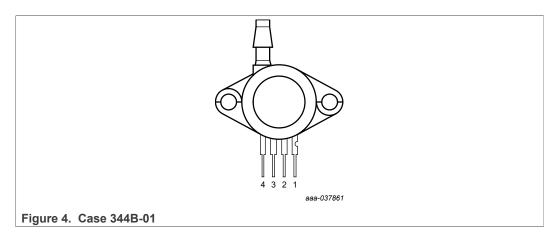


Table 3. Pin definitions - MPX2010GP

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output

6.4 MPXM2010GS/GST1

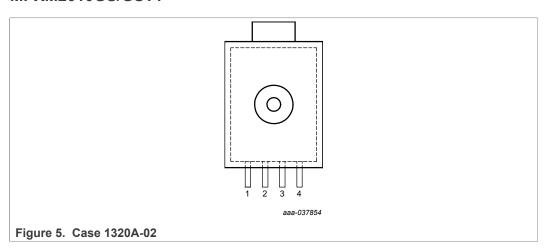


Table 4. Pin definitions - MPXM2010GS/GST1

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output

6.5 MPXV2010GP

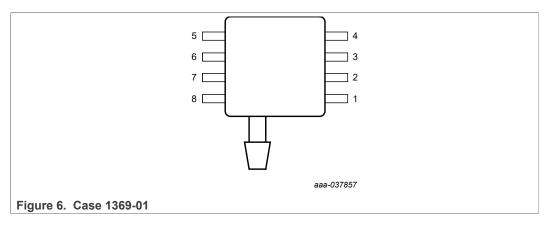


Table 5. Pin definitions - MPXV2010GP

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output
n.a.	5	_
n.a.	6	_
n.a.	7	_
n.a.	8	_

6.6 MPXV2010DP

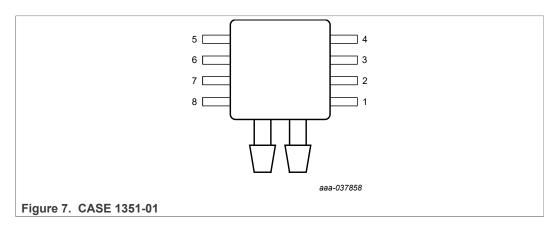


Table 6. Pin definitions - MPXV2010DP

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output
n.a.	5	_
n.a.	6	_
n.a.	7	_
n.a.	8	_

6.7 MPX2010GSX

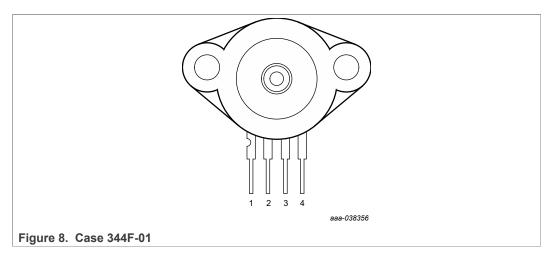


Table 7. Pin definitions - MPX2010GSX

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output

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7 Maximum Ratings

Table 8. Maximum ratings

Exposure beyond the specified limits may cause permanent damage or degradation to the device. In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
P _{max}	Overpressure	P1 > P2	_	_	75	kPa
P _{burst}	Burst Pressure	P1 > P2	_	_	100	kPa
T _{stg}	Storage Temperature		-40	_	+125	°C
T _A	Operating Temperature		-40	_	+125	°C

8 Operating Characteristics

Table 9. Operating characteristics ($V_S = 10 \text{ Vdc}$, $T_A = 25 \,^{\circ}\text{C}$ unless otherwise noted, P1 > P2)

Characteristic		Symbol	Min	Тур	Max	Units
Operating Pressure Range	[1]	P _{OP}	0	_	10	kPa
Supply Voltage	[2]	Vs	_	10	16	Vdc
Supply Current		lo	_	6.0	_	mAdc
Full Scale Span	[3]	V_{FSS}	24	25	26	mV
Offset	[4]	$V_{\rm off}$	-1.0	_	1.0	mV
Sensitivity		ΔV/ΔΡ	_	2.5	_	mV/kPa
Linearity	[5]	_	-1.0	_	1.0	%V _{FSS}
Pressure Hysteresis (0 kPa to 10 kPa)	[5]	_	_	±0.1	_	%V _{FSS}
Temperature Hysteresis (–40 °C to +125 °C)	[5]	_	_	±0.5	_	%V _{FSS}
Temperature Coefficient of Full Scale Span	[5]	TCV _{FSS}	-1.0	_	1.0	%V _{FSS}
Temperature Coefficient of Offset	[5]	TCV _{off}	-1.0	_	1.0	mV
Input Impedance		Z _{in}	1300	_	2550	Ω
Output Impedance		Z _{out}	1400	_	3000	Ω
Response Time (10% to 90%)	[6]	t _R	_	1.0	<u>—</u>	ms
Warm-Up Time	[7]	_	_	20	_	ms
Offset Stability	[8]	_	_	±0.5	_	%V _{FSS}

- [1] 1.0 kPa equals 0.145 PSI.
- Device is ratiometric within this specified excitation range. Operating the device above the specified excitation range may induce additional error due to device self-heating.
- [3] Full scale span (V_{FSS}) is defined as the algebraic difference between the output voltage at full rated pressure and the output voltage at the minimum rated pressure.
- [4] Offset (V_{off}) is defined as the output voltage at the minimum rated pressure.
- [5] Accuracy (error budget) consists of the following:
 - · Linearity: Output deviation from a straight line relationship with pressure using the end point method over the specified pressure range.
 - Temperature Hysteresis: Output deviation at any temperature within the operating temperature range, after the temperature is cycled to and from the minimum or maximum operating temperature points, with zero differential pressure applied.
 - Pressure Hysteresis: Output deviation at any pressure within the specified range, when this pressure is cycled to and from the minimum or maximum rated pressure, at 25 °C.
 - TcSpan: Output deviation at full rated pressure over the temperature range of 0 °C to 85 °C, relative to 25 °C
 - TcOffset: Output deviation with minimum rated pressure applied, over the temperature range of 0 °C to 85 °C, relative to 25 °C
- [6] Response Time is defined as the time for the incremental change in the output to go from 10% to 90% of its final value when subjected to a specified step change in pressure.
- [7] Warm-Up Time is defined as the time required for the product to meet the specified output voltage after the pressure has been stabilized.
- [8] Offset Stability is the product's output deviation when subjected to 1000 hours of Pulsed Pressure Temperature Cycling with Bias test.

9 Characteristics

9.1 Voltage output versus applied differential pressure

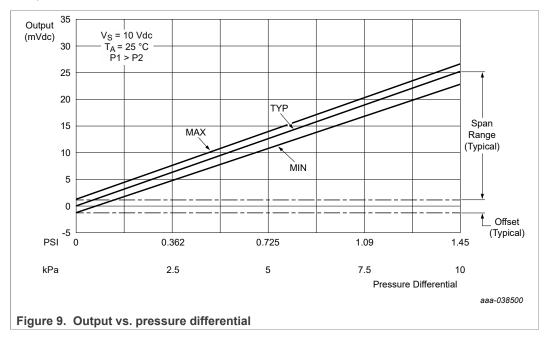
The output voltage of the differential or gauge sensor increases with increasing pressure applied to the pressure side (P1) relative to the vacuum side (P2). Similarly, output voltage increases as increasing vacuum is applied to the vacuum side (P2) relative to the pressure side (P1).

9.2 On-chip temperature compensation and calibration

Figure 9 shows the typical output characteristics of the MPX2010 series at 25 °C.

The effects of temperature on full scale span and offset are very small and are shown under <u>Section 8 "Operating Characteristics"</u>.

This performance over temperature is achieved by having both the shear stress strain gauge and the thin-film resistor circuitry on the same silicon diaphragm. Each chip is dynamically laser trimmed for precise span and offset calibration and temperature compensation.



9.3 Linearity

Linearity refers to how well a transducer's output follows the equation $V_{out} = V_{off} + Sensitivity \times P$ over the operating pressure range (<u>Figure 10</u>). There are two basic methods for calculating nonlinearity:

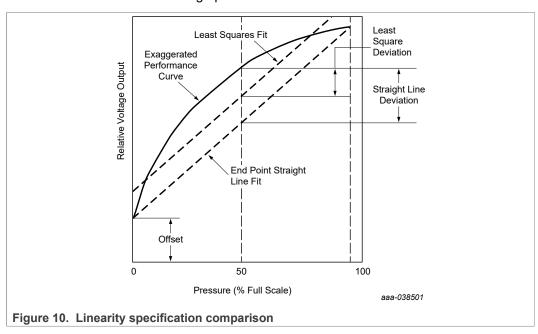
- · End point straight line fit
- · Least squares best line fit

While a least squares fit gives the "best case" linearity error (lower numerical value), the calculations required are burdensome.

MPX2010

Conversely, an end point fit will give the "worst case" error (often more desirable in error budget calculations) and the calculations are more straightforward for the user.

NXP's specified pressure sensor linearities are based on the end point straight line method measured at the midrange pressure.



9.4 Pressure (P1) / Vacuum (P2) side identification

NXP designates the two sides of the pressure sensor as the Pressure (P1) side and the Vacuum (P2) side. The Pressure (P1) side is the side containing silicone gel that isolates the die from the environment. The NXP MPX pressure sensor is designed to operate with positive differential pressure applied, P1 > P2.

The Pressure (P1) side may be identified by using Table 10.

Table 10. Pressure (P1) side delineation table

Part Number	Case Type	Pressure (P1) Side Identifier
MPX2010D	344	Stainless Steel Cap
MPX2010DP	344C	Side with Part Marking
MPX2010GP	344B	Side with Port Attached
MPX2010GSX	344F	Side with Port Attached
MPXV2010GP	1369	Side with Port Attached
MPXV2010DP	1351	Side with Part Marking
MPXM2010GS/GSTI	1320A	Side with Port Attached

9.5 Media compatibility

<u>Figure 11</u> illustrates the differential or gauge configuration in a typical chip carrier. A silicone gel isolates the die surface and wire bonds from the environment while allowing the pressure signal to be transmitted to the silicon diaphragm.

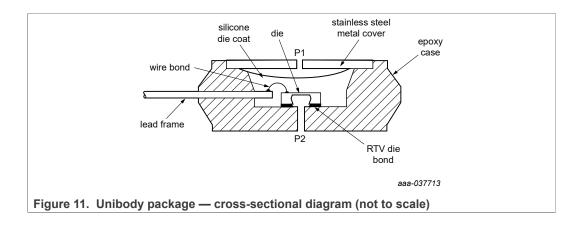
MPX2010

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Operating characteristics, internal reliability and qualification tests are based on the use of dry clean air as the pressure medium. Media other than dry clean air may have adverse effects on sensor performance and long term reliability. Contact the factory for information regarding media compatibility in your application.

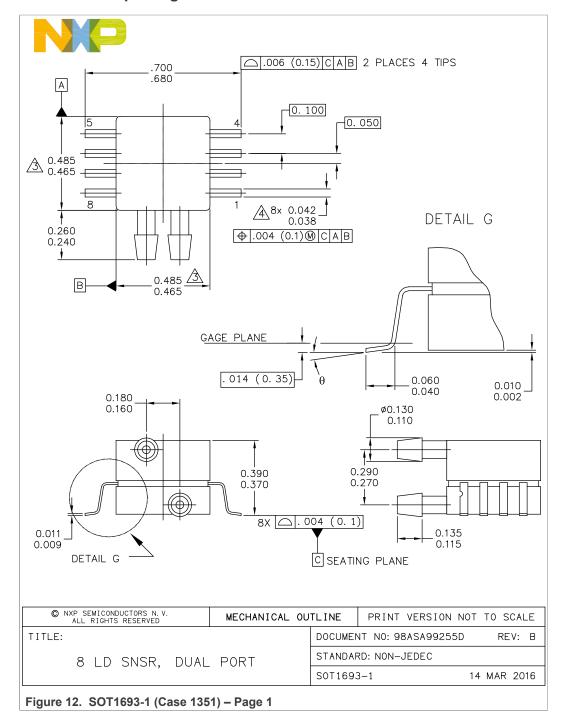
For more information, refer to application note AN3728.



10 Package Outlines

Package dimensions are provided in package drawings. To find the most current package outline drawing, go to https://www.nxp.com/ and perform a keyword search for the drawing's document number.

10.1 Small outline packages





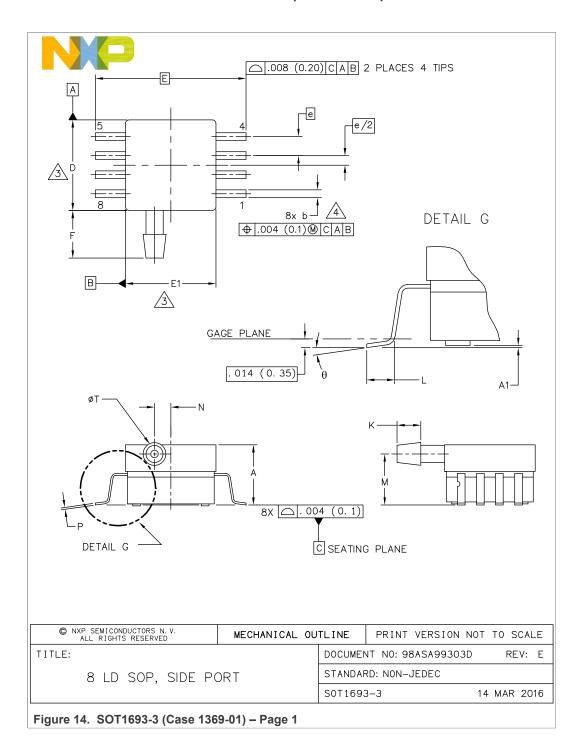
NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PPROTRUSIONS.
 MOLD FLASH AND PROTRUSIONS SHALL NOT EXCEED .006 PER SIDE.
- DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .008 MAXIMUM.

STYLE 1:		STYLE 2:	
PIN 1:	GND	PIN 1:	N/C
PIN 2:	+Vout	PIN 2:	٧s
PIN 3:	٧s	PIN 3:	GND
PIN 4:	−Vout	PIN 4:	Vout
PIN 5:	N/C	PIN 5:	N/C
PIN 6:	N/C	PIN 6:	N/C
PIN 7:	N/C	PIN 7:	N/C
PIN 8:	N/C	PIN 8:	N/C

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		S0T1693	3-1	14 MAR 2016

Figure 13. SOT1693-1 (Case 1351) - Page 2





NOTES:
1. CONTROLLING DIMENSION: INCH

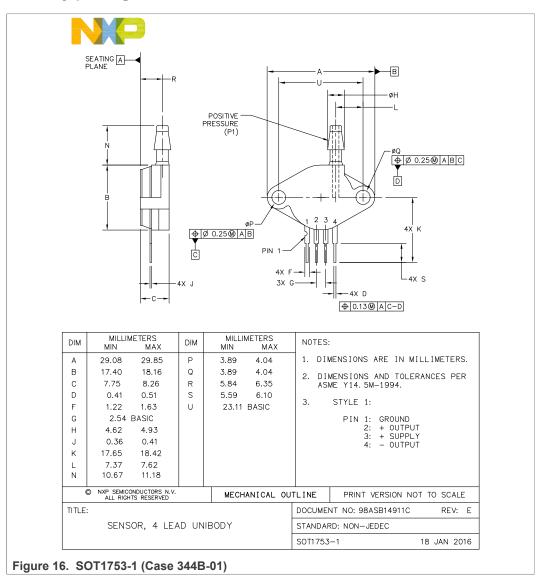
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

- A DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PPROTRUSIONS. MOLD FLASH AND PROTRUSIONS SHALL NOT EXCEED .006 (0.152) PER SIDE.
- $\underline{\cancel{\mbox{\mbox{Δ}}}}$ DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .008 (0.203) MAXIMUM.

	INC	HES	MIL	LIMETERS		INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
Α	.300	.330	7.62	8.38	θ	0.	7.	0.	7.
A1	.002	.010	0.05	0.25	_				
b	.038	.042	0.96	1.07	_				
D	.465	.485	11.81	12.32	_				
E	.717	BSC	18	.21 BSC	_				
E1	.465	.485	11.81	12.32	_				
e	.100	BSC	2.	54 BSC	_				
F	.245	.255	6.22	6.47	-				
K	.120	.130	3.05	3.30	_				
L	.061	.071	1.55	1.80	_				
м	.270	.290	6.86	7.36	_				
N	.080	.090	2.03	2.28	_				
P	.009	.011	0.23	0.28	_				
Т	.115	.125	2.92	3.17	_				
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	8 LD SOP, SIDE PORT					STANDARD: NON-JEDEC			
	,					S0T1693	3–3	14	MAR 2016

Figure 15. SOT1693-3 (Case 1369-01) - page 2

10.2 Unibody packages



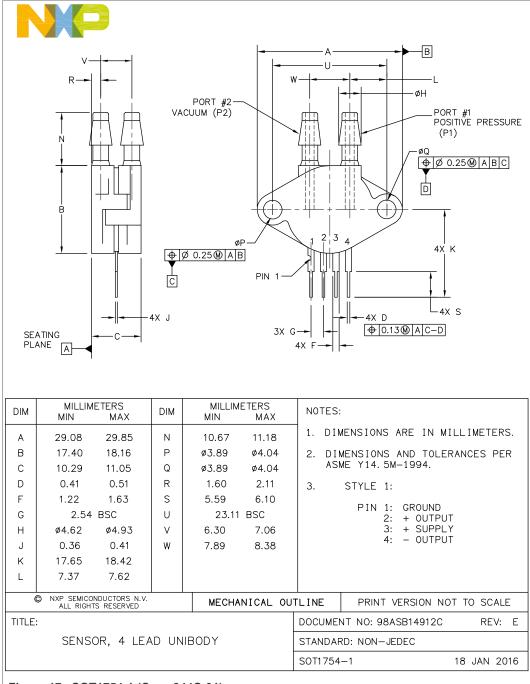
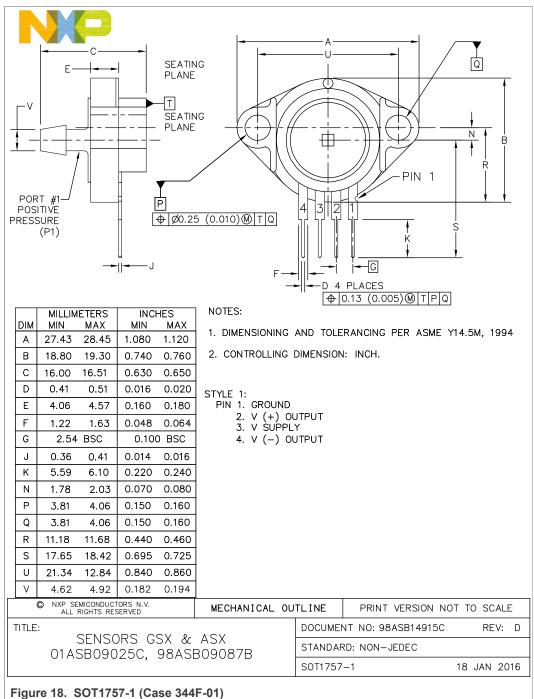
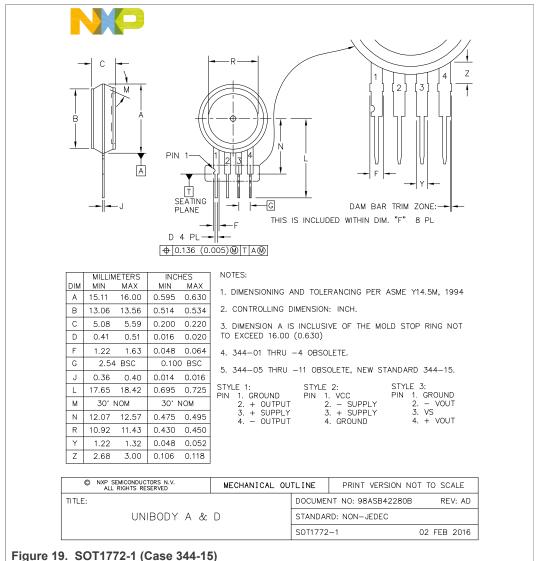
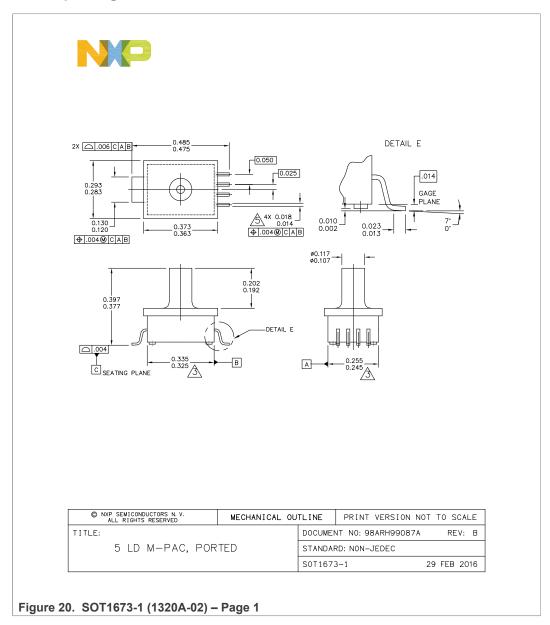


Figure 17. SOT1754-1 (Case 344C-01)





10.3 MPAK packages





NOTES

- 1. DIMENSIONS ARE IN INCHES.
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4. ALL VERTICAL SURFACES TO BE 5" MAXIMUM.

 $\stackrel{\triangle}{\triangle}$ dimension does not include dambar protrusion. Allowable dambar protrusion shall be .008 maximum.

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		SO.	T1673-1 29 FEB 2016

Figure 21. SOT1673-1 (1320A-02) - Page 2

11 References

- [1] AN840 Temperature Compensation Methods For The Motorola X-ducer Pressure Sensor Element https://www.nxp.com/docs/en/application-note/AN840.pdf
- [2] AN1984 Handling Freescale Pressure Sensors https://www.nxp.com/docs/en/application-note/AN1984.pdf
- [3] AN3150 Soldering Recommendations for Pressure Sensor Devices https://www.nxp.com/docs/en/application-note/AN3150.pdf
- [4] AN1318 Interfacing Semiconductor Pressure Sensors to Microcomputers https://www.nxp.com/docs/en/application-note/AN1318.pdf
- [5] AN3728 Media Compatibility for IPS PRT Pressure Sensors https://www.nxp.com/docs/en/application-note/AN3728.pdf

12 Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
MPX2010 v.14	20210427	Released	_	MPX2010 v.13	
Modifications	 Redesigned the data sheet to comply with the new identity guidelines of NXP Semiconductors. Adapted legal texts to the new company name where appropriate. Removed the following discontinued part numbers throughout: MPX2010GS 				
MPX2010 v.13	200810	Released	_	MPX2010 v.12	

13 Legal information

13.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition		
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.		
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.		
Product [short] data sheet	Production	This document contains the product specification.		

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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10 kPa Temperature Compensated Pressure Sensors

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